CMOS Digital Integrated Circuits Silicon Monolithic

TC74VCX574FT

1. Functional Description

Low-Voltage Octal D-Type Flip-Flop with 3.6-V Tolerant Inputs and Outputs

2. General

The TC74VCX574FT is a high performance CMOS octal D-type flip-flop which is guaranteed to operate from 1.2 V to 3.6 V. Designed for use in 1.5 V, 1.8 V, 2.5 V or 3.3 V systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

It is also designed with over voltage tolerant inputs and outputs up to 3.6 V.

This 8 bit D-type flip-flop is controlled by a clock input (CK) and an output enable input (\overline{OE}). When the \overline{OE} input is high, the eight outputs are in a high impedance state.

All inputs are equipped with protection circuits against static discharge.

3. Features

- (1) Wide operating temperature range: $T_{opr} = -40$ to 125 °C (Note 1)
- (2)Low-voltage operation: $V_{CC} = 1.2$ to 3.6 V
- High-speed operation: $t_{pd} = 4.2 \text{ ns} (\text{max}) (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$ (3)

$$t_{pd}$$
 = 4.8 ns (max) (V_{CC} = 2.3 to 2.7 V)
 t_{pd} = 9.6 ns (max) (V_{CC} = 1.65 to 1.95 V)
 t_{pd} = 19.2 ns (max) (V_{CC} = 1.4 to 1.6 V)

$$t_{nd} = 48.0 \text{ ns} (max) (V_{CC} = 1.2 \text{ V})$$

Output current: $I_{OH}/I_{OL} = \pm 24$ mA (min) ($V_{CC} = 3.0$ V) (4)

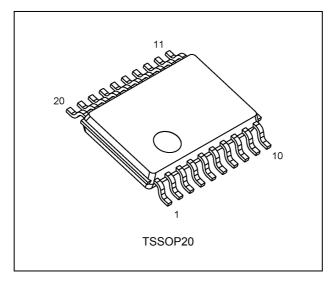
 $I_{OH}/I_{OL} = \pm 18 \text{ mA} \text{ (min)} (V_{CC} = 2.3 \text{ V})$

$$I_{OH}/I_{OL} = \pm 6 \text{ mA} \text{ (min)} (V_{CC} = 1.65 \text{ V})$$

 $I_{OH}/I_{OL} = \pm 2 \text{ mA} \text{ (min)} (V_{CC} = 1.4 \text{ V})$

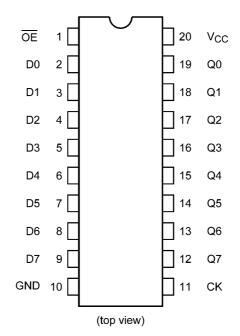
- Latch-up performance: -300 mA (5)
- (6)ESD performance: Human Body Model $\geq \pm 2000$ V
- 3.6 V tolerant function and power-down protection provided on all inputs and outputs. (7)
- Note 1: Operating Range spec of Topr = -40 °C to 125 °C is applicable only for the products which manufactured after April 2020.

4. Packaging

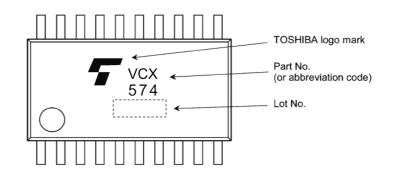


Start of commercial production 2020-04 2020-09-07

5. Pin Assignment



6. Marking



7. IEC Logic Symbol

$ \begin{array}{c} \overline{OE} & (1) \\ CK & (11) \\ D0 & (2) \\ D1 & (3) \\ D2 & (4) \end{array} $	EN > C1 1D	Þ	▼	<u>(19)</u> Q0 <u>(18)</u> Q1 (17) Q2
D3 <u>(5)</u> D4 <u>(6)</u> D5 <u>(7)</u>				<u>(16)</u> Q3 (15) Q4 (14) Q5
D6 <u>(8)</u> D7 <u>(9)</u>				(13) (12) (12) (12) (12)

8. Truth Table

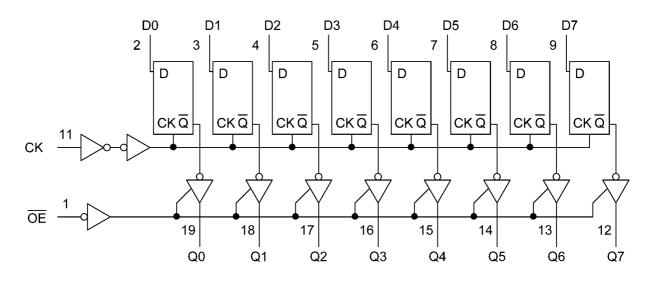
	Inputs	Outputs	
ŌĒ	ск	D	Outputs
н	X	Х	Z
L		Х	Qn
L		L	L
L		н	Н

X: Don't care

Z: High impedance

Qn: No change

9. System Diagram



10. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V _{CC}		-0.5 to 4.6	V
Input voltage	V _{IN}		-0.5 to 4.6	V
Output voltage	V _{OUT}	(Note 1)	-0.5 to 4.6	V
		(Note 2)	-0.5 to V _{CC} + 0.5	
Input diode current	I _{IK}		-50	mA
Output diode current	I _{ОК}	(Note 3)	±50	mA
Output current	I _{OUT}		±50	mA
Power dissipation	PD	(Note 4)	180	mW
V _{CC} /ground current	I _{CC} /I _{GND}		±100	mA
Storage temperature	T _{stg}		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Output in OFF state.

Note 2: High (H) or Low (L) state. $I_{\mbox{OUT}}$ absolute maximum rating must be observed.

Note 3: V_{OUT} < GND, V_{OUT} > V_{CC}

Note 4: 180 mW in the range of $T_a = -40$ to 85 °C. From $T_a = 85$ to 125 °C a derating factor of -3.25 mW/°C shall be applied until 50 mW.

11. Operating Ranges (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V _{CC}		1.2 to 3.6	V
Input voltage	V _{IN}		-0.3 to 3.6	V
Output voltage	V _{OUT}	(Note 1)	0 to 3.6	V
		(Note 2)	0 to V _{CC}	
Output current	I _{OH} ,I _{OL}	(Note 3)	±24	mA
		(Note 4)	±18	
		(Note 5)	±6	
		(Note 6)	±2	
Operating temperature	T _{opr}	(Note 7)	-40 to 125	°C
Input rise and fall times	dt/dv	(Note 8)	0 to 10	ns/V

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either V_{CC} or GND.

Note 1: Output in OFF state.

Note 2: High (H) or Low (L) state.

Note 3: V_{CC} = 3.0 to 3.6 V

Note 4: V_{CC} = 2.3 to 2.7 V

Note 5: V_{CC} = 1.65 to 1.95 V

Note 6: V_{CC} = 1.4 to 1.6 V

Note 7: Operating Range spec of T_{opr} = -40 °C to 125 °C is applicable only for the products which manufactured after April 2020.

Note 8: V_{IN} =0.8 to 2.0 V , V_{CC} = 3.0 V

12. Electrical Characteristics

12.1. DC Characteristics (Unless otherwise specified, $T_a = -40$ to 85 °C)

Characteristics	Symbol	Test Condition		V _{CC} (V)	Min	Max	Unit
High-level input voltage	V _{IH}	_		1.2 to 1.4	$V_{CC} imes 0.8$	_	V
				1.4 to 1.65	$V_{CC} imes 0.65$	_	
				1.65 to 2.3	$V_{CC} imes 0.65$	_	
				2.3 to 2.7	1.6	_	
				2.7 to 3.6	2.0	_	
Low-level input voltage	VIL	_		1.2 to 1.4	—	$V_{CC} \times 0.05$	V
				1.4 to 1.65	—	$V_{CC} imes 0.05$	
				1.65 to 2.3	_	$V_{CC} \times 0.2$	
				2.3 to 2.7	_	0.7	
				2.7 to 3.6	_	0.8	
High-level output voltage	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.2	V _{CC} - 0.1	_	V
				1.4 to 1.65	V _{CC} - 0.2	_	
				1.65 to 3.6	V _{CC} - 0.2	_	
			I _{OH} = -2 mA	1.4	1.05	_	
			I _{OH} = -6 mA	1.65	1.25	_	
				2.3	2.0	_	
			I _{OH} = -12 mA	2.3	1.8	_	
				2.7	2.2	_	
			I _{OH} = -18 mA	2.3	1.7	_	
				3.0	2.4	_	
			I _{OH} = -24 mA	3.0	2.2	_	
Low-level output voltage	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	1.2	_	0.05	V
				1.4 to 1.65	—	0.05	
				1.65 to 3.6	—	0.2	
			I _{OL} = 2 mA	1.4	—	0.35	
			I _{OL} = 6 mA	1.65	—	0.3	
			I _{OL} = 12 mA	2.3	—	0.4	
				2.7	_	0.4	
			I _{OL} = 18 mA	2.3	_	0.6	
				3.0	_	0.4	
			I _{OL} = 24 mA	3.0	_	0.55	
Input leakage current	I _{IN}	V _{IN} = 0 to 3.6 V	•	1.2 to 3.6	—	±5.0	μA
3-state output OFF-state leakage current	I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = 0 to 3.6 V		1.2 to 3.6	—	±10.0	μA
Power-OFF leakage current	I _{OFF}	V_{IN}/V_{OUT} = 0 to 3.6 V		0	_	10.0	μA
Quiescent supply current	I _{CC}	V _{IN} = V _{CC} or GND		1.2 to 3.6	_	20.0	μA
		$V_{CC} \le (V_{IN}/V_{OUT}) \le 3.6 \text{ V}$		1.2 to 3.6	_	±20.0	
	Δl _{CC}	V _{IH} = V _{CC} - 0.6 V (per input)		2.7 to 3.6		750	μA

12.2. DC Characteristics (Note) (Unless otherwise specified, $T_a = -40$ to 125 °C)

Characteristics	Symbol	Test Condition	า	V _{CC} (V)	Min	Max	Unit
High-level input voltage	V _{IH}	—		1.2 to 1.4	$V_{CC} imes 0.8$	—	V
				1.4 to 1.65	$V_{CC} imes 0.65$	—	
				1.65 to 2.3	$V_{CC} imes 0.65$	_	
				2.3 to 2.7	1.6	—	
				2.7 to 3.6	2.0	—	
Low-level input voltage	VIL	—		1.2 to 1.4	_	$V_{CC} imes 0.05$	V
				1.4 to 1.65	_	$V_{CC} imes 0.05$	
				1.65 to 2.3	—	$V_{CC} imes 0.2$	
				2.3 to 2.7	_	0.7	
				2.7 to 3.6	—	0.8	
High-level output voltage	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.2	V _{CC} - 0.1	—	V
				1.4 to 1.65	V _{CC} - 0.2	—	
				1.65 to 3.6	V _{CC} - 0.2	—	
			I _{OH} = -2 mA	1.4	1.05	_	
			I _{OH} = -6 mA	1.65	1.25	_	
				2.3	2.0	_	
			I _{OH} = -12 mA	2.3	1.8	_	
				2.7	2.2	_	
			I _{OH} = -18 mA	2.3	1.6	—	
				3.0	2.4	_	
			I _{OH} = -24 mA	3.0	2.2	—	
Low-level output voltage	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	1.2	_	0.05	V
				1.4 to 1.65	—	0.05	
				1.65 to 3.6	—	0.2	
			I _{OL} = 2 mA	11.4	_	0.35	
			I _{OL} = 6 mA	1.65	—	0.3	
			I _{OL} = 12 mA	2.3	—	0.4	
				2.7	—	0.4	
			I _{OL} = 18 mA	2.3	—	0.8	
				3.0	—	0.4	
			I _{OL} = 24 mA	3.0	—	0.55	
Input leakage current	I _{IN}	V _{IN} = 0 to 3.6 V	•	1.2 to 3.6	—	±20.0	μA
3-state output OFF-state leakage current	I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = 0 to 3.6 V		1.2 to 3.6		±40.0	μA
Power-OFF leakage current	I _{OFF}	V _{IN} /V _{OUT} = 0 to 3.6 V		0	_	40.0	μA
Quiescent supply current	I _{CC}	V _{IN} = V _{CC} or GND		1.2 to 3.6	—	80.0	μA
		$V_{CC} \le (V_{IN}/V_{OUT}) \le 3.6 \text{ V}$		1.2to 3.6	—	±80.0	
	Δl _{CC}	V _{IH} = V _{CC} - 0.6 V (per input)		2.7 to 3.6	—	1.5	mA

Note: Operating Range spec of T_{opr} = -40 °C to 125 °C is applicable only for the products which manufactured after April 2020.

12.3. AC Characteristics (Unless otherwise specified, $T_a = -40$ to 85 °C)

Characteristics	Symbol	Note	Test Condition	V _{CC} (V)	Min	Max	Unit
Maximum clock frequency	f _{MAX}		See 12.7 AC Test Circuit,	1.2	40	—	MHz
			Table 12.7.1, Fig. 12.8.1, Table 12.8.1	1.5 ± 0.1	80	_	
				1.8 ± 0.15	100	_	
				2.5 ± 0.2	200		
				$\textbf{3.3}\pm\textbf{0.3}$	250	_	
Propagation delay time	t _{PLH} ,t _{PHL}		See 12.7 AC Test Circuit,	1.2	1.5	48.0	ns
(CK-Q)			Table 12.7.1, Fig. 12.8.1, Table 12.8.1	1.5 ± 0.1	1.0	19.2	
				1.8 ± 0.15	1.5	9.6	
				2.5 ± 0.2	0.8	4.8	
				3.3 ± 0.3	0.6	4.2	
3-state output enable time	t _{PZL} ,t _{PZH}		See 12.7 AC Test Circuit,	1.2	1.5	49.0	ns
			Table 12.7.1, Fig. 12.8.2, Table 12.8.1	1.5 ± 0.1	1.0	19.6	
				1.8 ± 0.15	1.5	9.8	
				2.5 ± 0.2	0.8	5.5	
				3.3 ± 0.3	0.6	4.5	
3-state output disable time	t _{PLZ} ,t _{PHZ}		See 12.7 AC Test Circuit, Table 12.7.1, Fig. 12.8.2, Table 12.8.1	1.2	1.5	32.5	ns
				1.5 ± 0.1	1.0	13.0	
				1.8 ± 0.15	1.5	6.5	
				2.5 ± 0.2	0.8	3.6	
				3.3 ± 0.3	0.6	3.3	
Minimum pulse width	t _{w(L)} ,t _{w(H)}		See 12.7 AC Test Circuit, Table 12.7.1, Fig. 12.8.1, Table 12.8.1	1.2	24.0	—	ns
(CK)				1.5 ± 0.1	8.0	—	
				1.8 ± 0.15	4.0	—	
				2.5 ± 0.2	1.5	—	
				3.3 ± 0.3	1.5	_	
Minimum setup time	ts		See 12.7 AC Test Circuit,	1.2	20.0	_	ns
			Table 12.7.1, Fig. 12.8.1,	1.5 ± 0.1	7.5	_	
			Table 12.8.1	1.8 ± 0.15	2.5	_	
				2.5 ± 0.2	1.5	_	
				3.3 ± 0.3	1.5		
Minimum hold time	t _h		See 12.7 AC Test Circuit,	1.2	8.0	_	ns
			Table 12.7.1, Fig. 12.8.1,	1.5 ± 0.5	3.0	_	
			Table 12.8.1	1.8 ± 0.15	1.0	_	
				2.5 ± 0.2	1.0	_	
				3.3 ± 0.3	1.0	_	
Output skew	t _{osLH} ,t _{osHL}	(Note 1)	_	1.2		1.5	ns
				1.5 ± 0.1		1.5	
				1.8 ± 0.15		0.5	
				2.5 ± 0.2	_	0.5	
				3.3 ± 0.3	_	0.5	

Note 1: Parameter guaranteed by design. $(t_{osLH} = |t_{PLH}m-t_{PLH}n|, t_{osHL} = |t_{PHL}m-t_{PHL}n|)$

12.4. AC Characteristics (Note) (Unless otherwise specified, $T_a = -40$ to 125 °C)

Characteristics	Symbol	Note	Test Condition	V _{CC} (V)	Min	Max	Unit
Maximum clock frequency	f _{MAX}		See 12.7 AC Test Circuit,	1.2	30	_	MHz
			Table 12.7.1, Fig. 12.8.1, Table 12.8.1	1.5 ± 0.1	70	_	
				1.8 ± 0.15	80	_	1
				2.5 ± 0.2	150	_	1
				$\textbf{3.3}\pm\textbf{0.3}$	200	_	
Propagation delay time	t _{PLH} ,t _{PHL}		See 12.7 AC Test Circuit,	1.2	1.5	63.0	ns
(CK-Q)			Table 12.7.1, Fig. 12.8.1, Table 12.8.1	1.5 ± 0.1	1.0	24.4	
				1.8 ± 0.15	1.5	11.4	
				2.5 ± 0.2	0.8	5.7	
				$\textbf{3.3}\pm\textbf{0.3}$	0.6	5.0	1
3-state output enable time	t _{PZL} ,t _{PZH}		See 12.7 AC Test Circuit,	1.2	1.5	60.0	ns
			Table 12.7.1, Fig. 12.8.2, Table 12.8.1	1.5 ± 0.1	1.0	23.2	1
				1.8 ± 0.15	1.5	11.6	1
				2.5 ± 0.2	0.8	6.5	
				$\textbf{3.3}\pm\textbf{0.3}$	0.6	5.4	1
3-state output disable time	t _{PLZ} ,t _{PHZ}		See 12.7 AC Test Circuit, Table 12.7.1, Fig. 12.8.2, Table 12.8.1	1.2	1.5	41.5	ns
				1.5 ± 0.1	1.0	15.6	1
				1.8 ± 0.15	1.5	7.8	1
				$\textbf{2.5}\pm\textbf{0.2}$	0.8	4.4	1
				$\textbf{3.3}\pm\textbf{0.3}$	0.6	4.0	
Minimum pulse width	t _{w(L)} ,t _{w(H)}		See 12.7 AC Test Circuit, Table 12.7.1, Fig. 12.8.1, Table 12.8.1	1.2	26.0	_	ns
(CK)				1.5 ± 0.1	8.7	_	
				1.8 ± 0.15	4.4	_	1
				2.5 ± 0.2	1.7	_	1
				$\textbf{3.3}\pm\textbf{0.3}$	1.7	_	1
Minimum setup time	ts		See 12.7 AC Test Circuit,	1.2	21.0	_	ns
			Table 12.7.1, Fig. 12.8.1,	1.5 ± 0.1	7.9	_	1
			Table 12.8.1	1.8 ± 0.15	2.7	_	
				$\textbf{2.5}\pm\textbf{0.2}$	1.6	_	1
				$\textbf{3.3}\pm\textbf{0.3}$	1.6	_	1
Minimum hold time	t _h		See 12.7 AC Test Circuit,	1.2	8.4	_	ns
			Table 12.7.1, Fig. 12.8.1,	1.5 ± 0.1	3.2	_	1
			Table 12.8.1	1.8 ± 0.15	1.1	_	1
				$\textbf{2.5}\pm\textbf{0.2}$	1.1	_	1
				$\textbf{3.3}\pm\textbf{0.3}$	1.1	_	1
Output skew	t _{osLH} ,t _{osHL}	(Note 1)	_	1.2	_	2.0	ns
				1.5 ± 0.1	_	2.0	
				1.8 ± 0.15	_	1.0	1
				2.5 ± 0.2		1.0	1
				3.3 ± 0.3	_	1.0	1

Note: Operating Range spec of T_{opr} = -40 °C to 125 °C is applicable only for the products which manufactured after April 2020.

Note 1: Parameter guaranteed by design. $(t_{osLH} = |t_{PLH}m-t_{PLH}n|, t_{osHL} = |t_{PHL}m-t_{PHL}n|)$

12.5. Dynamic Switching Characteristics (Note) (Unless otherwise specified, $T_a = 25^{\circ}$ C, Input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Quiet output maximum dynamic V _{OL}	V _{OLP}	V _{IH} = 1.8 V, V _{IL} = 0 V	1.8	0.25	V
		V _{IH} = 2.5 V, V _{IL} = 0 V	2.5	0.6	
		V _{IH} = 3.3 V, V _{IL} = 0 V	3.3	0.8	
Quiet output minimum dynamic V_{OL}	V _{OLV}	V _{IH} = 1.8 V, V _{IL} = 0 V	1.8	-0.25	V
		V _{IH} = 2.5 V, V _{IL} = 0 V	2.5	-0.6	
		V _{IH} = 3.3 V, V _{IL} = 0 V	3.3	-0.8	
Quiet output minimum dynamic V _{OH}	V _{OHV}	V _{IH} = 1.8 V, V _{IL} = 0 V	1.8	1.5	V
		V _{IH} = 2.5 V, V _{IL} = 0 V	2.5	1.9	
		V _{IH} = 3.3 V, V _{IL} = 0 V	3.3	2.2	

Note 1: Parameter guaranteed by design.

12.6. Capacitive Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Note	Test Condition	V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}		—	1.8, 2.5, 3.3	6	pF
Output capacitance	C _{OUT}		—	1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C _{PD}	(Note 1)	f _{IN} = 10 MHz	1.8, 2.5, 3.3	20	pF

Note 1: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

 $I_{CC}(opr) = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}/8 \text{ (per 1 gate)}$

12.7. AC Test Circuit

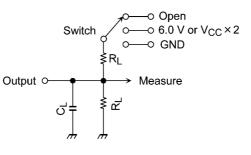


Table 12.7.1 Parameter for AC Test Circuit

Parameter	Switch	Test Condition
t _{PLH} , t _{PHL}	OPEN	—
t _{PLZ} , t _{PZL}	6.0 V	V_{CC} = 3.3 \pm 0.3 V
	$V_{CC} \times 2$	V_{CC} = 2.5 \pm 0.2 V
		V_{CC} = 1.8 \pm 0.15 V
		V_{CC} = 1.5 \pm 0.1 V
		V _{CC} = 1.2 V
t _{PHZ} , t _{PZH}	GND	_

12.8. AC Waveform

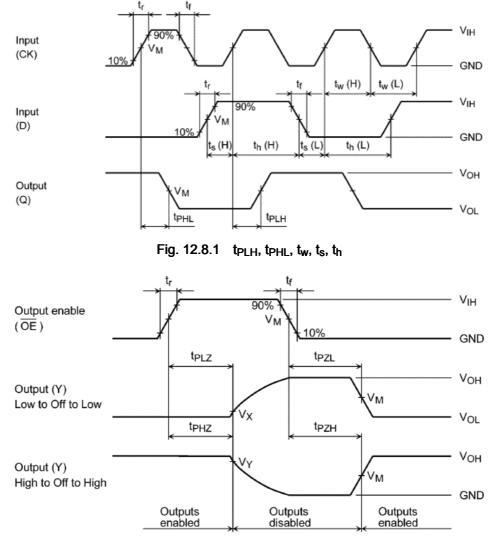


Fig. 12.8.2 t_{PLZ}, t_{PHZ}, t_{PZL}, t_{PZH}

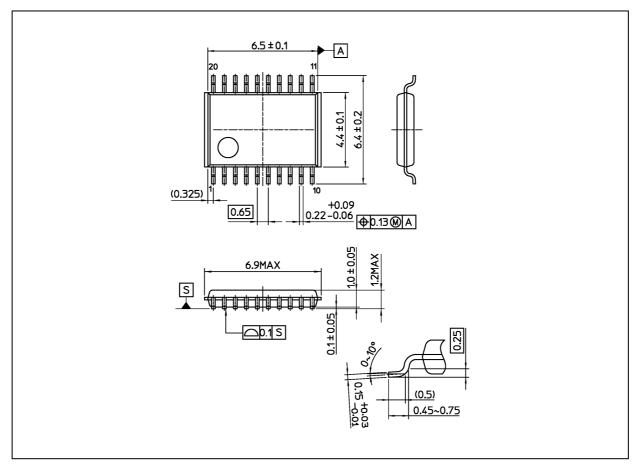
Table 12.8.1	AC Waveform Symbols
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	Symbol	V_{CC} = 3.3 \pm 0.3 V	V_{CC} = 2.5 ± 0.2 V V_{CC} = 1.8 ± 0.15 V	V_{CC} = 1.5 ± 0.1 V V_{CC} = 1.2 V
Input	V _{IH}	2.7 V	V _{CC}	V _{CC}
	V _M	1.5 V	V _{CC} /2	V _{CC} /2
	t _r , t _f	2.0 ns	2.0 ns	2.0 ns
Output	V _M	1.5 V	V _{CC} /2	V _{CC} /2
	V _X	V _{OL} + 0.3 V	V _{OL} + 0.15 V	V _{OL} + 0.15 V
	V _Y	V _{OH} - 0.3 V	V _{OH} - 0.15 V	V _{OH} - 0.15 V
Load	CL	30 pF	30 pF	15 pF
	RL	500 Ω	500 Ω	2 kΩ

TC74VCX574FT

Package Dimensions

Unit: mm



Weight: 0.08 g (typ.)

	Package Name(s)	
Nickname: TSSOP20		

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